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|-----------------------------------|---------------------------------------|--|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/563,135 |  | Applicant(s)/Patent Under<br>Reexamination<br>MOILANEN, TEUVO |             |
|                                   | Examiner<br>ROBERT T. REESE           |  | Art Unit<br>3654  | Page 1 of 1 |

#### U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                     | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-3,872,473 A                                   | 03-1975         | Melgaard et al.          | 340/520        |
| * | B | US-3,894,250 A                                   | 07-1975         | Hager et al.             | 327/511        |
| * | C | US-2002/0165953 A1                               | 11-2002         | Diong, Chong Khai        | 709/224        |
| * | D | US-6,928,976 B2                                  | 08-2005         | H.ang.kansson, Nils-Olof | 123/196R       |
|   | E | US-  |                 |                          |                |
|   | F | US-  |                 |                          |                |
|   | G | US-  |                 |                          |                |
|   | H | US-  |                 |                          |                |
|   | I | US-  |                 |                          |                |
|   | J | US-  |                 |                          |                |
|   | K | US-  |                 |                          |                |
|   | L | US-  |                 |                          |                |
|   | M | US-  |                 |                          |                |

#### FOREIGN PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

#### NON-PATENT DOCUMENTS

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U | Honeywell Incorporated, Hall Effect Sensing and Application, 11/1998                      |
|   | V |   |
|   | W |   |
|   | X |   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.